


<b>Search Notes</b> 	<b>Application/Control No.</b> 10591943	<b>Applicant(s)/Patent Under Reexamination</b> JU ET AL.
	<b>Examiner</b> QUN SHEN	<b>Art Unit</b> 2617

SEARCHED			
Class	Subclass	Date	Examiner
370	331, 250, 251, 252 combined with text	2/3/2010	QS
455	436, 445	2/3/2010	QS

SEARCH NOTES			
Search Notes		Date	Examiner
TEST SEARCH ON EAST		2/26/2010	QS
International search report		2/3/2010	QS
inventor search		2/3/2010	QS
NPL search		2/25/2010	QS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/QUN SHEN/  
Examiner,Art Unit 2617